· -	1			•
L Number	Hits	Search Text	DB	Time stamp
1	756	photoresist\$4 same (bubble or shell)	USPAT; US-PGPUB	2003/07/25 10:23
2	115	(photoresist\$4 same (bubble or shell))	USPAT;	2003/07/25
3	38	and electron and microscop\$2 ((photoresist\$4 same (bubble or shell))	US-PGPUB USPAT;	10:23 2003/07/25
		and electron and microscop\$2) and (flood\$3 or inspect\$4)	US-PGPUB	10:35
4	2104	250/310	USPAT;	2003/07/25
5	1646	250/311	US-PGPUB USPAT;	10:35 2003/07/25
6	2446	250/306	US-PGPUB USPAT;	10:35
			US-PGPUB	2003/07/25 10:35
7	2044	250/307	USPAT; US-PGPUB	2003/07/25
8	393	(250/310 or 250/311 or 250/306 or 250/307) and photoresist\$4	USPAT;	2003/07/25
9	338	((250/310 or 250/311 or 250/306 or	US-PGPUB USPAT;	11:17 2003/07/25
10	82	250/307) and photoresist\$4) and layer (((250/310 or 250/311 or 250/306 or	US-PGPUB USPAT;	11:17 2003/07/25
		250/307) and photoresist\$4) and layer) and electron and inspect\$4	US-PGPUB	11:17
11	79	((((250/310 or 250/311 or 250/306 or	USPAT;	2003/07/25
		250/307) and photoresist\$4) and layer) and electron and inspect\$4) and	US-PGPUB	11:18
12	11	microscop\$2 (US-6143666-\$ or US-5783366-\$ or	USPAT	2003/07/25
		US-6444381-\$ or US-5510216-\$ or	OSFAI	11:15
		US-6420702-\$ or US-6589709-\$ or US-6358670-\$ or US-5928821-\$ or		
		US-5242864-\$ or US-6121130-\$ or US-5747803-\$).did.		
13	148	430/16	USPAT	2003/07/25
14	512	430/23	USPAT	11:15
15	1939	430/30	USPAT	11:15 2003/07/25
16	1898	430/296	USPAT	11:15
				11:16
17	3011	430/311	USPAT	2003/07/25
18	984	438/623	USPAT	2003/07/25
19	637	438/701	USPAT	2003/07/25
20	823	438/725	USPAT	11:16
21	4652	(430/16 or 430/23 or 430/30 or 430/296 or	USPAT;	11:16 2003/07/25
		430/311 or 438/623 or 438/701 or 438/725) and photoresist\$4	US-PGPUB	11:17
22	4311	((430/16 or 430/23 or 430/30 or 430/296	USPAT;	2003/07/25
		or 430/311 or 438/623 or 438/701 or 438/725) and photoresist\$4) and layer	US-PGPUB	11:17
23	304	(((430/16 or 430/23 or 430/30 or 430/296 or 430/311 or 438/623 or 438/701 or	USPAT; US-PGPUB	2003/07/25 11:18
		438/725) and photoresist\$4) and layer)	JJ FGFUD	11.10
24	149	and electron and inspect\$4 ((((430/16 or 430/23 or 430/30 or 430/296	USPAT;	2003/07/25
		or 430/311 or 438/623 or 438/701 or 438/725) and photoresist\$4) and layer)	US-PGPUB	11:18
		and electron and inspect\$4) and microscop\$2		
25	13	(((((430/16 or 430/23 or 430/30 or	USPAT;	2003/07/25
		430/296 or 430/311 or 438/623 or 438/701 or 438/725) and photoresist\$4) and layer)	US-PGPUB	11:18
		and electron and inspect\$4) and microscop\$2) and flood\$3		
<u> </u>		wroroscobds) and IIOOdds		

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-	5579	inspect\$4 and (Electron adj microscop\$4)	USPAT;	2003/07/23
_	5944	inspect\$4 and (Electron adj microscop\$4)	US-PGPUB USPAT;	17:30 2003/07/23
	3344	inspector and (bleetion ad) microscops4)	US-PGPUB;	13:19
			EPO;	13.13
			DERWENT	
_	4132		USPAT;	2003/07/23
		microscop\$4)) and layer\$3	US-PGPUB; EPO;	13:20
			DERWENT	
i -	427	((inspect\$4 and (Electron adj	USPAT;	2003/07/23
		microscop\$4)) and layer\$3) and untreat\$3	US-PGPUB;	15:32
		and treat\$4	EPO;	
		"09820143"	DERWENT	
-	"	09020143"	USPAT; US-PGPUB;	2003/07/23
			EPO;	13:26
			DERWENT	
_	52		USPAT;	2003/07/23
		microscop\$4)) and layer\$3) and untreat\$3	US-PGPUB;	15:42
		and treat\$4) and photoresist\$3	EPO;	
_	728	//ingnocts/ and /Plastner add	DERWENT	2002/07/22
_	/28	((inspect\$4 and (Electron adj microscop\$4)) and layer\$3) and	USPAT; US-PGPUB;	2003/07/23
		((untreat\$3 and treat\$4) or (expos\$3 and	EPO;	13.34
	1	unexpos\$3) or (radiat\$3 and unradiat\$3))	DERWENT	
-	579	((inspect\$4 and (Electron adj	USPAT;	2003/07/23
		microscop\$4)) and layer\$3) and	US-PGPUB;	15:34
		((untreat\$3 same treat\$4) or (expos\$3	EPO;	
		<pre>same unexpos\$3) or (radiat\$3 same unradiat\$3))</pre>	DERWENT	
_	159		USPAT;	2003/07/23
		microscop\$4)) and layer\$3) and	US-PGPUB;	15:58
		((untreat\$3 same treat\$4) or (expos\$3	EPO;	
		same unexpos\$3) or (radiat\$3 same	DERWENT	
		unradiat\$3))) and photoresist\$3		
_	26	((((inspect\$4 and (Electron adj microscop\$4)) and layer\$3) and	USPAT;	2003/07/24
		((untreat\$3 same treat\$4) or (expos\$3	US-PGPUB; EPO;	08:59
		same unexpos\$3) or (radiat\$3 same	DERWENT	
		unradiat\$3))) and photoresist\$3) and		
		flood\$3		
-	18	okoroanyanwu.in.	USPAT;	2003/07/23
			US-PGPUB; EPO;	17:29
	ļ		DERWENT	
-	160	singh-bhanwar.in.	USPAT;	2003/07/23
			US-PGPUB;	17:29
			EPO;	
_	0	acheta-alden.in.	DERWENT	2002/07/22
	"	acheta-aluen.in.	USPAT; US-PGPUB;	2003/07/23 17:29
			EPO;	21.63
			DERWENT	
-	35	, (USPAT;	2003/07/23
_	•	and (Electron adj microscop\$4)	US-PGPUB	17:30
_	1	((okoroanyanwu.in. or singh-bhanwar.in.) and (Electron adj microscop\$4)) and	USPAT;	2003/07/23
		untreat\$3	US-PGPUB	17:30
- !	676	·	USPAT;	2003/07/24
		(integrat\$3 adj circuit\$3)	US-PGPUB;	10:38
	!		EPO;	
_	C 1 1	/lawaré2 and floodé2 and nhatawariana2	DERWENT	2002/07/04
<u> </u>	511	(layer\$3 and flood\$3 and photoresist\$3 and (integrat\$3 adj circuit\$3)) and	USPAT;	2003/07/24
		region	US-PGPUB; EPO;	10:30
			DERWENT	
=	442		USPAT;	2003/07/24
		and (integrat\$3 adj circuit\$3)) and	US-PGPUB;	10:40
-		region) and reduc\$5	EPO;	
			DERWENT	

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	· · · · · · · · · · · · · · · · · · ·			
-	20	(((==]==() ===== ======================	USPAT;	2003/07/24
		and (integrat\$3 adj circuit\$3)) and	US-PGPUB;	11:10
		region) and reduc\$5) and shell	EPO;	
			DERWENT	
-	88		USPAT;	2003/07/24
		and (integrat\$3 adj circuit\$3)) and	US-PGPUB;	11:16
		region) and reduc\$5) and inspec\$5	EPO;	
			DERWENT	
-	40	((((layer\$3 and flood\$3 and photoresist\$3	USPAT;	2003/07/24
		and (integrat\$3 adj circuit\$3)) and	US-PGPUB;	12:28
		region) and reduc\$5) and inspec\$5) and	EPO;	
	-	enclos\$3	DERWENT	
-	266052	inspect\$4 amd electron and (electron adj	USPAT;	2003/07/24
		microscop\$2) and (integrated adj circuit)	US-PGPUB;	12:38
	1		EPO;	
			DERWENT	1
-	10485	(inspect\$4 amd electron and (electron adj	USPAT;	2003/07/24
		microscop\$2) and (integrated adj	US-PGPUB;	12:44
		circuit)) and layer and surface and	EPO;	12.33
		transforms	DERWENT	
-	624		USPAT;	2003/07/24
		adj microscop\$2) and (integrated adj	US-PGPUB;	12:45
		circuit)) and layer and surface and	EPO;	
		transform\$) and ((enclos\$3 or	DERWENT	
1		encapsulat\$3) near4 (surface or layer))		Į l
-	45		USPAT;	2003/07/24
		adj microscop\$2) and (integrated adj	US-PGPUB;	12:45
		circuit)) and layer and surface and	EPO;	
		transform\$) and ((enclos\$3 or	DERWENT	
i		encapsulat\$3) near4 (surface or layer)))		į į
		and photoresist		
_	52	(((inspect\$4 amd electron and (electron	USPAT;	2003/07/24
		adj microscop\$2) and (integrated adj	US-PGPUB;	15:01
1		circuit)) and layer and surface and	EPO;	
	ļ	transform\$) and ((enclos\$3 or	DERWENT	[
		encapsulat\$3) near4 (surface or layer)))		
		and photoresist\$3		
-	527	(shell or (cross adj link\$4)) and	USPAT;	2003/07/24
		(barrier or trap\$4) and layer and	US-PGPUB;	15:03
		outgas\$4	EPO;	
		-	DERWENT	
j -	47	((shell or (cross adj link\$4)) and	USPAT;	2003/07/24
	i	(barrier or trap\$4) and layer and	US-PGPUB;	15:07
		outgas\$4) and photoresist\$4	EPO;	
			DERWENT	
-	2	5330881.pn.	USPAT;	2003/07/24
			US-PGPUB;	15:07
			EPO;	
!]		DERWENT	
-	811		USPAT;	2003/07/25
		and (electron adj microscop\$2) and	US-PGPUB	08:41
		electron and beam		
[- i	181	(inspect\$3 and (integrat\$3 adj circuit)	USPAT;	2003/07/25
		and (electron adj microscop\$2) and	US-PGPUB	08:42
		electron and beam) and ((treat\$4 or		
]		transform\$5) same surface)		
-	12	(inspect\$3 and (integrat\$3 adj circuit)	USPAT;	2003/07/25
		and (electron adj microscop\$2) and	US-PGPUB	08:43
		electron and beam) and ((treat\$4 or		ſ
		transform\$5) same surface same ("SEM" or	ł	
		microscop\$2) same inspect\$4)		
-	12	((inspect\$3 and (integrat\$3 adj circuit)	USPAT;	2003/07/25
		and (electron adj microscop\$2) and	US-PGPUB	10:22
		electron and beam) and ((treat\$4 or		
		transform\$5) same surface)) and ((treat\$4		
		or transform\$5) same surface same ("SEM"		
L <u></u>		or microscop\$2) same inspect\$4)		